


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539757	<b>Applicant(s)/Patent Under Reexamination</b>  YOSHIDA ET AL.
	<b>Examiner</b>  DEREK S CHAPEL	<b>Art Unit</b>  2872

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the case.	3/3/2008	DSC
EAST Class/Subclass Search: 359/202, 212-213, 362, 371, 384-387, 495, 500 (text only)	3/1/2008	DSC
EAST update search	8/20/2008	DSC
EAST text search	8/26/2008	DSC
EAST Class/Subclass Search: 351/205-221 (text only, see attached)	8/26/2008	DSC
Consulted with Thong Nguyen about the case.	8/26/2008	DSC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference Search, see .clm. search	2/29/2008	DSC
	Interference Search, see .clm. searches attached		

/D. S. C. /  
Examiner, Art Unit 2872